## MOSFET – Power, Single, N-Channel, DPAK/IPAK 30 V, 117 A

## Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- AEC Q101 Qualified NVD4804N
- These Devices are Pb-Free and are RoHS Compliant

#### Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	V <sub>DSS</sub>	30	V		
Gate-to-Source Voltage	е		V <sub>GS</sub>	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	19.6	А
Current (R <sub>0JA</sub> ) (Note 1)		T <sub>A</sub> = 85°C		15.2	
Power Dissipation $(R_{\theta JA})$ (Note 1)		$T_A = 25^{\circ}C$	PD	2.66	W
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	14.5	Α
Current (R <sub>0JA</sub> ) (Note 2)	Steady	$T_A = 85^{\circ}C$		11	
Power Dissipation $(R_{\theta JA})$ (Note 2)	State	$T_A = 25^{\circ}C$	P <sub>D</sub>	1.43	W
Continuous Drain		$T_C = 25^{\circ}C$	I <sub>D</sub>	124	Α
Current (R <sub>θJC</sub> ) (Note 1)		$T_{C} = 85^{\circ}C$		96	
Power Dissipation $(R_{\theta JC})$ (Note 1)		$T_C = 25^{\circ}C$	PD	107	w
Pulsed Drain Current	t <sub>p</sub> =10μs	$T_A = 25^{\circ}C$	I <sub>DM</sub>	230	Α
Current Limited by Packa	age	T <sub>A</sub> = 25°C	I <sub>DmaxPkg</sub>	45	А
Operating Junction and S	Storage Te	emperature	T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C
Source Current (Body Di	iode)		۱ <sub>S</sub>	78	А
Drain to Source dV/dt	dV/dt	6.0	V/ns		
$ \begin{array}{l} \mbox{Single Pulse Drain-to-S} \\ \mbox{Energy (V_{DD} = 24 V, V_{GS})} \\ \mbox{L = 1.0 mH, } \\ \mbox{I}_{L(pk)} = 30 \mbox{ A} \end{array} $	E <sub>AS</sub>	450	mJ		
Lead Temperature for So (1/8" from case for 10 s)	Idering Pu	rposes	ΤL	260	°C

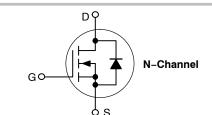
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

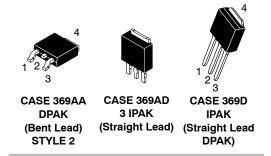


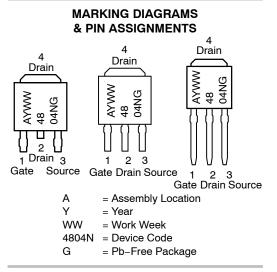
## **ON Semiconductor®**

### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	4.0 m $\Omega$ @ 10 V	117 A
00 V	5.5 mΩ @ 4.5 V	







#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	R <sub>θJC</sub>	1.4	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	R <sub>θJA</sub>	56.4	
Junction-to-Ambient - Steady State (Note 2)	$R_{ extsf{ heta}JA}$	105	

Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub>	= 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				26		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μA
		$V_{DS} = 24 V$	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							

Gate Threshold Voltage  $V_{GS}=V_{DS},\,I_{D}=250\;\mu A$ 1.5 2.5 V V<sub>GS(TH)</sub> Negative Threshold Temperature mV/°C V<sub>GS(TH)</sub>/T<sub>J</sub> 7.6 Coefficient Drain-to-Source On Resistance  $V_{GS}$  = 10 to 11.5 V R<sub>DS(on)</sub> I<sub>D</sub> = 30 A 4.0 mΩ 3.4 I<sub>D</sub> = 15 A 3.4 V<sub>GS</sub> = 4.5 V I<sub>D</sub> = 30 A 4.7 5.5 I<sub>D</sub> = 15 A 4.6 gFS  $V_{DS} = 15 \text{ V}, \text{ I}_{D} = 15 \text{ A}$ S Forward Transconductance 23

#### CHARGES AND CAPACITANCES

Input Capacitance	C <sub>iss</sub>		4490		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 12 V	952		
Reverse Transfer Capacitance	C <sub>rss</sub>		556		
Total Gate Charge	Q <sub>G(TOT)</sub>		30	40	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	5.5		
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 30 A	13		
Gate-to-Drain Charge	Q <sub>GD</sub>		13		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 30 A	73		nC

#### SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	t <sub>d(on)</sub>		18	ns
Rise Time	t <sub>r</sub>		20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D$ = 15 A, $R_G$ = 3.0 $\Omega$	24	
Fall Time	t <sub>f</sub>		8	
Turn-On Delay Time	t <sub>d(on)</sub>		10	ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = 11.5 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 Ω	19	
Turn-Off Delay Time	t <sub>d(off)</sub>		35	
Fall Time	t <sub>f</sub>		5	

3. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

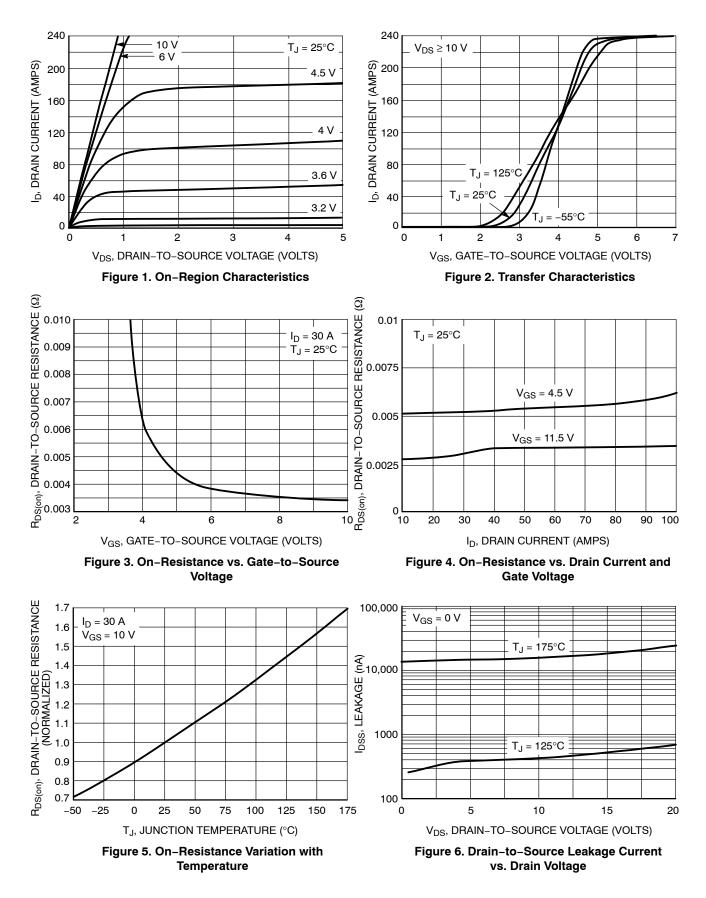
4. Switching characteristics are independent of operating junction temperatures.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

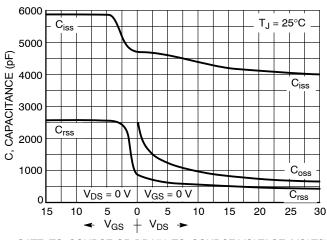
Parameter	Symbol	Test Condition		Min	Тур	Мах	Unit		
DRAIN-SOURCE DIODE CHARACTERISTICS									
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.81	1.2	V		
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.72				
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 30 A			34		ns		
Charge Time	ta				19				
Discharge Time	tb				15				
Reverse Recovery Time	Q <sub>RR</sub>				30		nC		
PACKAGE PARASITIC VALUES							-		
Source Inductance	L <sub>S</sub>				2.49		nH		
Drain Inductance, DPAK	L <sub>D</sub>				0.0164				
Drain Inductance, IPAK	L <sub>D</sub>	T <sub>A</sub> = 25°C			1.88		1		
Gate Inductance	L <sub>G</sub>	1			3.46		1		
Gate Resistance	R <sub>G</sub>	1			0.6		Ω		

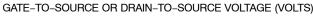
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

## **TYPICAL PERFORMANCE CURVES**



## **TYPICAL PERFORMANCE CURVES**







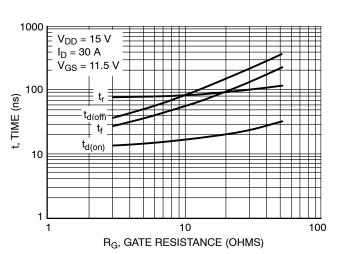


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

1000

100

10

1 0.1 V<sub>GS</sub> = 20 V

T<sub>C</sub> = 25°C

ID, DRAIN CURRENT (AMPS)

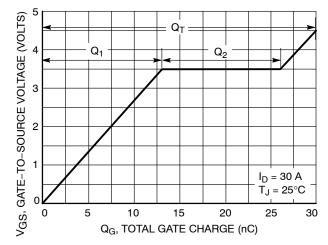


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

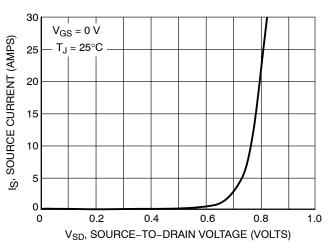
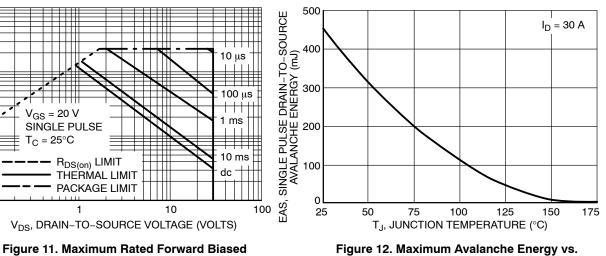


Figure 10. Diode Forward Voltage vs. Current



Safe Operating Area

1

**Starting Junction Temperature** 

## **TYPICAL PERFORMANCE CURVES**

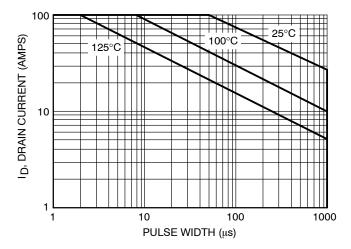
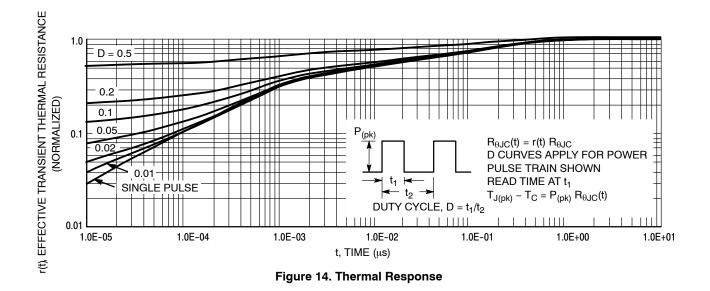


Figure 13. Avalanche Characteristics



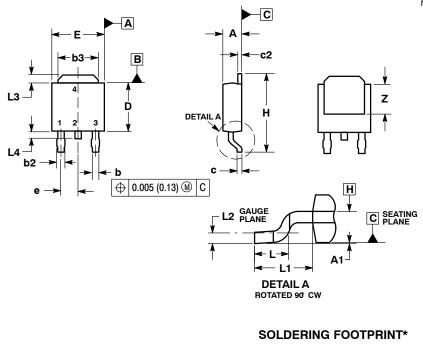
### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NTD4804NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4804N-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units / Rail
NVD4804NT4G	DPAK (Pb–Free)	2500 / Tape & Reel
NVD4804NT4G-VF01	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## PACKAGE DIMENSIONS

**DPAK (SINGLE GUAGE)** CASE 369AA **ISSUE B** 

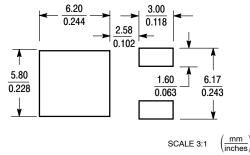


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: INCHES.
  THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
c	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090 BSC		2.29	BSC	
Η	0.370	0.410	9.40	10.41	
Г	0.055	0.070	1.40	1.78	
L1	0.108 REF		2.74 REF		
L2	0.020	BSC	0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Ζ	0.155		3.93		

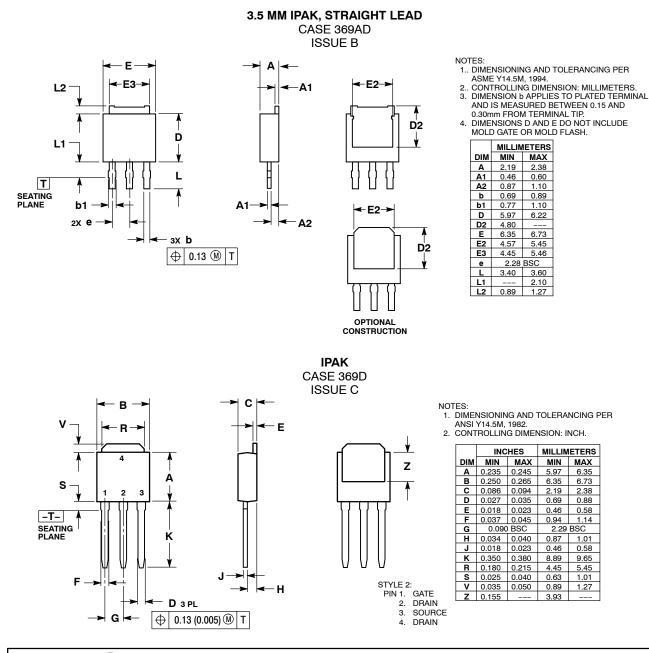
PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

STYLE 2:



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS



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